

# Current Transducer HAIS 50 ... 400-P HAIS 50 ... 150-TP

For the electronic measurement of current: DC, AC, pulsed..., with galvanic separation between the primary circuit and the secondary circuit.



All data are given with  $R_1 = 10 \text{ k}\Omega$ 

< 5

4.7

< 19

5

5 YEAR WARRANTY	c <b>FU</b> °us R⊠HS 🛵
by LEM	

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#### **Features**

· Hall effect measuring principle

50 ... 400 A

50 ... 150 A

- Galvanic separation between primary and secondary circuit
- Insulation test voltage 2500 V
- Low power consumption
- Single power supply +5 V
- · Fixed offset & sensitivity
- · Insulating plastic case recognized according to UL 94-V0.

# **Advantages**

Ω

nF

V

mΑ

- · Small size and space saving
- Only one design for wide current ratings range
- · High immunity to external interference
- $\bullet$   $U_{\rm ref}$  IN/OUT.

# **Applications**

- AC variable speed drives and servo motor drives
- Static converters for DC motor drives
- · Battery supplied applications
- Uninterruptible Power Supplies (UPS)
- Switched Mode Power Supplies (SMPS)
- Power supplies for welding applications.

#### **Application domain**

• Industrial.

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Prim	ary nominal	Primar	y current	Туре		
RMS	Scurrent $I_{PN}(A)$	measu	ring range $I_{\rm PM}({\sf A})$			
50		±150		HAIS 5	0-P/50-TP 1)	
100		±300		HAIS 1	00-P/100-TP <sup>1)</sup>	
150		±450		HAIS 1	50-P/150-TP <sup>1)</sup>	
200		±600		HAIS 2	00-P	
400		±600		HAIS 4	00-P	
$S_{N}$	Nominal sensitiv	vity @ 1	r P N		0.625	V/ I <sub>PN</sub>
$U_{ m out}$	Output voltage (	(Analog	) @ I <sub>P</sub>		$U_{\text{OE}}$ +(0.625·	
$U_{\mathrm{ref}}$	Reference volta	ige <sup>2)</sup>	Output voltage		2.5 ±0.025	V
			Output impedance	Э	typ. 200	Ω
			Load impedance		≥ 200	kΩ
$R_{\scriptscriptstyle 1}$	Load resistance	;			≥ 2	kΩ

# Accuracy - Dynamic performance data

Current consumption @  $U_c$  = 5 V

Output internal resistance

Load capacitance (±20 %)

Supply voltage (±5 %) 3)

ε	Error $^{4)}$ @ $I_{PN}$ , $T_{A}$ = 25 °C		≤ ±1	% of $I_{\rm PN}$
$\varepsilon_{\scriptscriptstyle \! L}$	Linearity error 0 $I_{PM}$		≤ ±0.5	% of $I_{PN}$
$TCU_{OE}$	Temperature coefficient of $U_{\text{OF}}$		≤ ±0.3	mV/K
$TCU_{ref}$	Temperature coefficient of $U_{\mathrm{ref}}$	+25 +85 °C	≤ ±0.01	%/K
		−40 +25 °C	≤ ±0.015	%/K
$TCU_{OE}/U_{I}$	Temperature coefficient of $U_{ m OE}/U_{ m C}$	ref	≤ ±0.2	mV/K
TCS	Temperature coefficient of $S$		$\leq \pm 0.05 \%$ of	reading/K
$U_{\text{OE}}$	Electrical offset voltage @ $I_P = 0$ ,	$T_{\rm A} = 25  {\rm ^{\circ}C}$	$U_{\rm ref}~{\pm}0.025$	V
$U_{OM}$	Magnetic offset voltage @ $I_P = 0$			
	after an overload of $I_{PM}$ HAIS 50-	P/TP	$< \pm 0.5$	% of $I_{PN}$
	HAIS 100-	P/TP 400-P	$< \pm 0.4$	% of $I_{PN}$
t <sub>D 10</sub>	Delay time to 10 % of the final outpo	ut value for $I_{PN}$ step	< 3	μs
t <sub>D 90</sub>	Delay time to 90 % of the final outp	out value for $I_{PN}$ step <sup>5)</sup>	< 5	μs
$U_{no}$	RMS noise voltage (DC 10	kHz)	< 15	mVpp
	(DC 1 I	MHz)	< 40	mVpp
BW	Frequency bandwidth (-3 dB) 6)		DC 50	kHz

#### Notes:

 $C_{\rm L}$   $U_{\rm C}$ 

<sup>1) -</sup>TP version is equipped with a primary bus bar; Temperature of primary bus bar should not exceed 100 °C

 $<sup>^{2)}</sup>$  It is possible to overdrive  $\it U_{\rm ref}$  with an external reference voltage between 1.5  $\dot{\text{V}}$  - 2.8 V providing its ability to sink or source approximately 5 mA

<sup>3)</sup> Maximum supply voltage (not operating) <6.5 V

<sup>4)</sup> Excluding offset and magnetic offset voltage

 $<sup>^{5)}</sup>$  Tested with 0 ... 125 A step with slope 100 A/ $\mu s$ 

<sup>&</sup>lt;sup>6)</sup> Small signal only to avoid excessive heatings of the magnetic core.



## Current Transducer HAIS 50 ... 400-P and HAIS 50 ... 150-TP

General data						
$T_{ m A} \ T_{ m Ast} \ m$	Ambient operating temperature Ambient storage temperature Mass (in brackets: TP version) Standards	-40 +85 -40 +85 20 (30) EN 50178: 1997	°C °C g			
Ins	ulation coordination					
$U_{ m d} \ U_{ m t}$	RMS voltage for AC insulation test, 50 Hz, 1 min Partial discharge RMS test voltage ( $q_m$ < 10 pC)	2.5	kV			
	HAIS 50 400-P	> 1	kV			
	HAIS 50 150-TP	> 1.4	kV			
$U_{\mathrm{Ni}}$	Impulse withstand voltage 1.2/50 μs	8 Min	kV			
$d_{Cp}$	Creepage distance	> 8	mm			
$d_{\text{CI}}$ $CTI$	Clearance distance Comparative Tracking Index (group I)	> 8 > 600	mm			

## **Applications examples**

According to EN 50178 and IEC 61010-1 standards and following conditions:

- Over voltage category OV 3
- Pollution degree PD2
- Non-uniform field

	EN 50178	IEC 61010-1
$d_{\mathrm{Cp}}$ , $d_{\mathrm{Cl}}$ , $U_{\mathrm{Ni}}$	Rated insulation voltage	Nominal voltage
Basic insulation	1000 V	1000 V
Reinforced insulation	600 V	300 V

## **Safety**

This transducer must be used in limited-energy secondary circuits according to IEC 61010-1.



This transducer must be used in electric/electronic equipment with respect to applicable standards and safety requirements in accordance with the manufacturer's operating instructions.



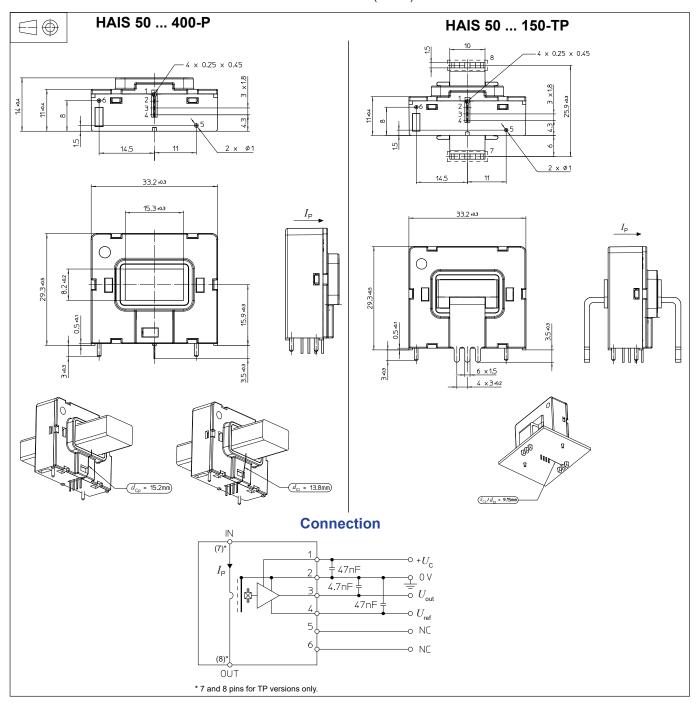
Caution, risk of electrical shock

When operating the transducer, certain parts of the module can carry hazardous voltage (e.g. primary busbar, power supply). Ignoring this warning can lead to injury and/or cause serious damage.

This transducer is a build-in device, whose conducting parts must be inaccessible after installation. A protective housing or additional shield could be used. Main supply must be able to be disconnected.



# **Dimensions HAIS 50 ... 400-P and HAIS 50 ... 150-TP (in mm)**



#### **Mechanical characteristics**

General tolerance ±0.2 mm

Primary through-hole 15.3 mm x 8.2 mm.

#### **Recommended PCB hole sizes**

Primary bus bar pins 7 and 8
 PCB hole 2.3 ±0.1 mm

(for TP versions only)

Secondary pins 1-4
 Support pins 5 and 6
 PCB hole 0.7 ±0.1 mm
 PCB hole 1.5 ±0.1 mm

# Remarks

- Magnetic core connected internally to 0 V for better dv/dt immunity
- $\bullet \ \ U_{\rm out}$  is positive when  $I_{\rm P}$  flows in the direction of the arrow
- Temperature of the primary conductor should not exceed 100 °C.